

## N-Channel SiC Power MOSFET

### Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Easy to Parallel and Simple to Drive

<b>V<sub>DS</sub></b>	=	<b>1200</b>	<b>V</b>
<b>R<sub>DS(on)</sub></b>	=	<b>16</b>	<b>mΩ</b>
<b>I<sub>D</sub>@25°C</b>	=	<b>120</b>	<b>A</b>

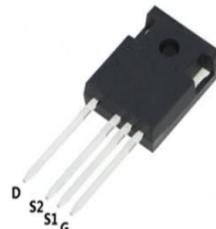
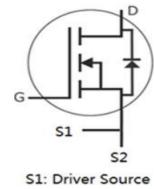
### Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

### Applications

- Solar and UPS inverters
- EV motor drive
- High voltage DC/DC converters
- Switched mode power supplies
- Load switch
- Halogen-free

### Package



Part Number	Package	Marking
RSM120N120T7L	TO-247-4	120N120

### Maximum Ratings ( $T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DSmax}$	Drain-Source Voltage	1200	V	$V_{GS}=0\text{V}$ , $I_D=100\mu\text{A}$	
$V_{GSmax}$	Gate-Source Voltage	-8/+22	V	<b>Absolute maximum values</b>	
$V_{GSop}$	Gate-Source Voltage	-4/+18	V	<b>Recommended operational values</b>	
$I_D$	Continuous Drain Current	120	A	$V_{GS}=18\text{V}$ , $T_c=25^\circ\text{C}$	Fig. 19
		85		$V_{GS}=18\text{V}$ , $T_c=100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	250	A	Pulse width $t_p$ limited by $T_{Jmax}$	Fig. 22
$P_D$	Power Dissipation	375	W	$T_c=25^\circ\text{C}$ , $T_J=175^\circ\text{C}$	Fig. 20
$T_J$ , $T_{STG}$	Operating Junction and Storage Temperature	-55 to +175	°C		
$T_L$	Solder Temperature, 1.6mm from case for 10s	260	°C		
$M_d$	Mounting Torque, (M3 or 6-32 screw)	1 8.8	Nm lbf-in		

## Electrical Characteristics ( $T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	1200	/	/	V	$V_{GS}=0\text{V}, I_D=100\mu\text{A}$	
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.9	2.6	4.0	V	$V_{DS}=V_{GS}, I_D=23\text{mA}$	Fig. 11
		/	1.8	/		$V_{DS}=V_{GS}, I_D=23\text{mA}, T_J=175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current	/	1	100	$\mu\text{A}$	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}$	
$I_{GSS+}$	Gate-Source Leakage Current	/	10	250	nA	$V_{DS}=0\text{V}, V_{GS}=22\text{V}$	
$I_{GSS-}$	Gate-Source Leakage Current	/	10	250	nA	$V_{DS}=0\text{V}, V_{GS}=-8\text{V}$	
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	/	16	22.3	$\text{m}\Omega$	$V_{GS}=18\text{V}, I_D=75\text{A}$	Fig. 4,5,6
		/	28	/		$V_{GS}=18\text{V}, I_D=75\text{A}, T_J=175^\circ\text{C}$	
$g_{fs}$	Transconductance	/	41.4	/	S	$V_{DS}=20\text{V}, I_{DS}=75\text{A}$	Fig. 7
		/	36.5	/		$V_{DS}=20\text{V}, I_{DS}=75\text{A}, T_J=175^\circ\text{C}$	
$C_{iss}$	Input Capacitance	/	4817	/	pF	$V_{GS}=0\text{V}$	Fig. 17,18
$C_{oss}$	Output Capacitance	/	207	/		$V_{DS}=1000\text{V}$	
$C_{rss}$	Reverse Transfer Capacitance	/	45	/		$f=1\text{MHz}$	
$E_{oss}$	$C_{oss}$ Stored Energy	/	104	/	$\mu\text{J}$	$V_{AC}=25\text{mV}$	Fig. 16
$E_{ON}$	Turn-On Switching Energy	/	2.1	/	mJ	$V_{DS}=800\text{V}, V_{GS}=-4\text{V}/18\text{V}$	
$E_{OFF}$	Turn-Off Switching Energy	/	1.6	/		$I_D=30\text{A}, R_{G(\text{ext})}=2.5\Omega, L=100\mu\text{H}$	
$t_{d(on)}$	Turn-On Delay Time	/	150	/			
$t_r$	Rise Time	/	38	/			
$t_{d(off)}$	Turn-Off Delay Time	/	108	/	ns	$V_{DS}=800\text{V}, V_{GS}=-4\text{V}/18\text{V}, I_D=30\text{A}$	
$t_f$	Fall Time	/	35	/		$R_{G(\text{ext})}=2.5\Omega, R_L=20\Omega$	
$R_{G(\text{int})}$	Internal Gate Resistance	/	4.5	/		$f=1\text{MHz}, V_{AC}=25\text{mV}$	
$Q_{GS}$	Gate to Source Charge	/	66	/	nC	$V_{DS}=800\text{V}$	Fig. 12
$Q_{GD}$	Gate to Drain Charge	/	48	/		$V_{GS}=-4\text{V}/18\text{V}$	
$Q_G$	Total Gate Charge	/	269	/		$I_D=30\text{A}$	

## Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode Forward Voltage	4.2	/	V	$V_{GS}=-4\text{V}, I_{SD}=37.5\text{A}, T_J=25^\circ\text{C}$	Fig. 8,9,10
		3.9	/		$V_{GS}=-4\text{V}, I_{SD}=37.5\text{A}, T_J=175^\circ\text{C}$	
$I_s$	Continuous Diode Forward Current	/	120	A	$T_c=25^\circ\text{C}$	
$t_{rr}$	Reverse Recover Time	54	/	ns	$V_R=800\text{V}, I_{SD}=30\text{A}$	
$Q_{rr}$	Reverse Recovery Charge	630	/	nC		
$I_{rrm}$	Peak Reverse Recovery Current	19	/	A		

## Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.23	/	°C/W		Fig. 21
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient	/	40			

## RATING AND CHARACTERISTICS CURVES (RSM120N120T7L)

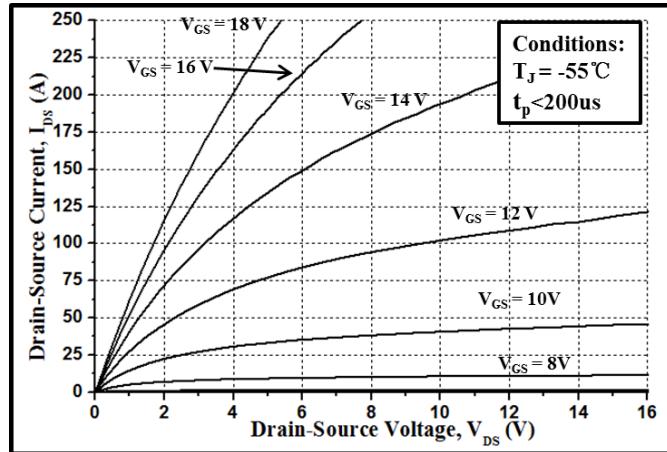


Figure 1. Output Characteristics  $T_J = -55^\circ\text{C}$

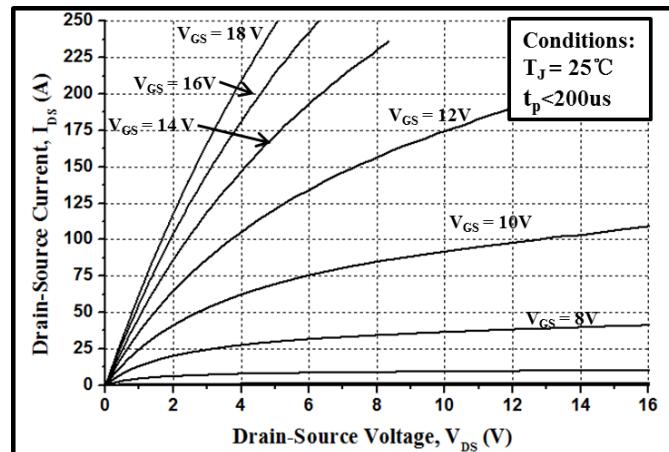


Figure 2. Output Characteristics  $T_J = 25^\circ\text{C}$

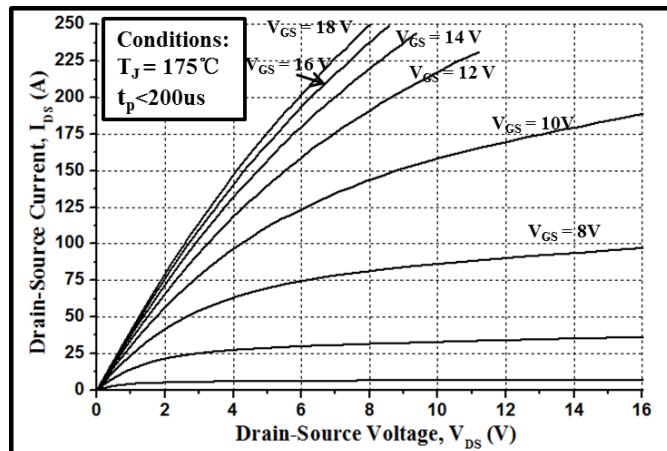


Figure 3. Output Characteristics  $T_J = 175^\circ\text{C}$

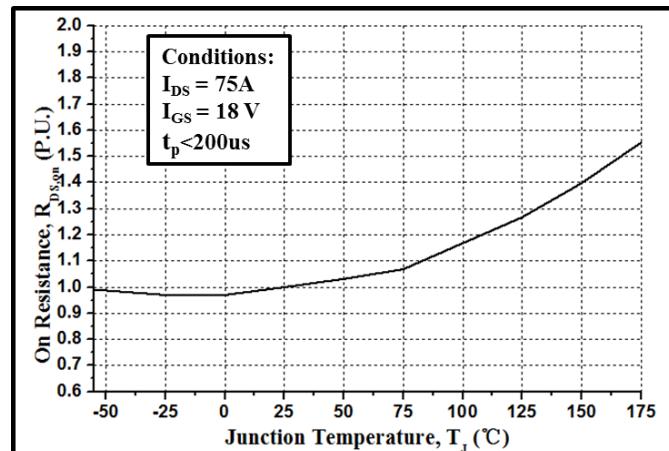


Figure 4. Normalized On-Resistance vs. Temperature

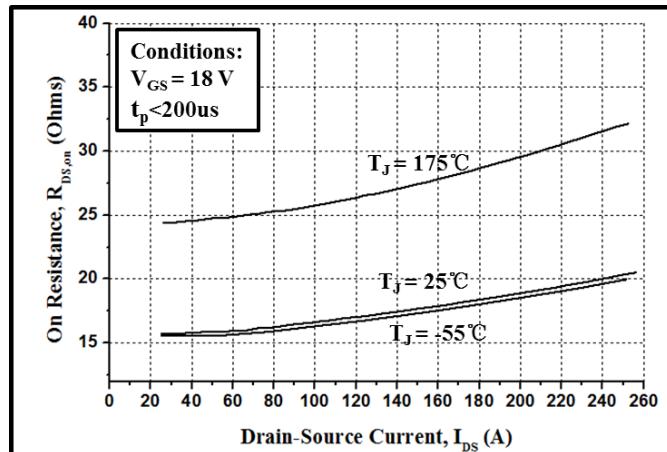


Figure 5. On-Resistance vs. Drain Current

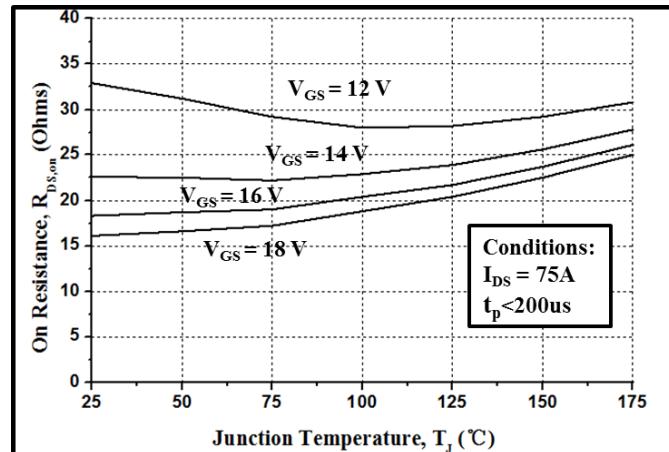


Figure 6. On-Resistance vs. Temperature

## RATING AND CHARACTERISTICS CURVES (RSM120N120T7L)

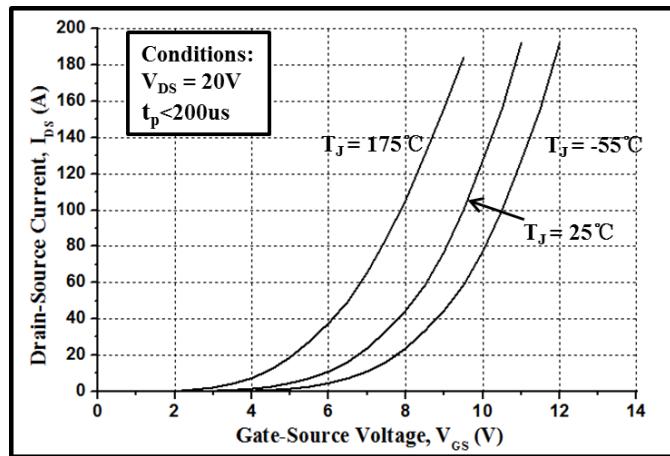


Figure 7. Transfer Characteristic for Various Junction Temperatures

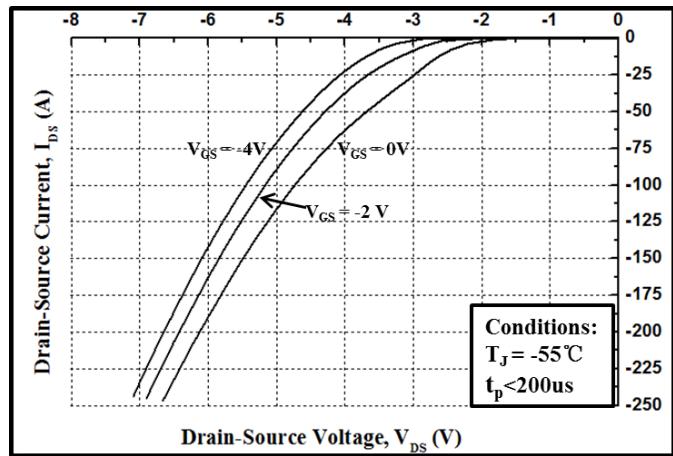


Figure 8. Body Diode Characteristic at  $-55^\circ C$

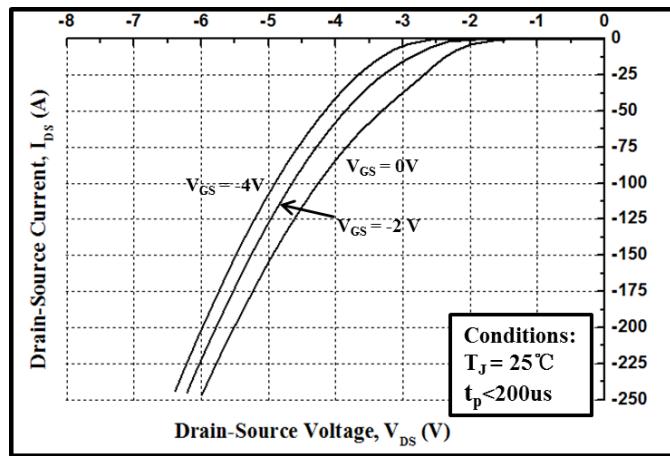


Figure 9. Body Diode Characteristic at  $25^\circ C$

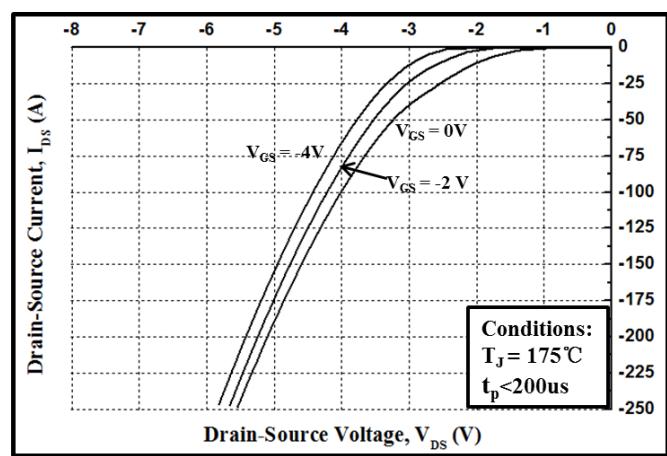


Figure 10. Body Diode Characteristic at  $175^\circ C$

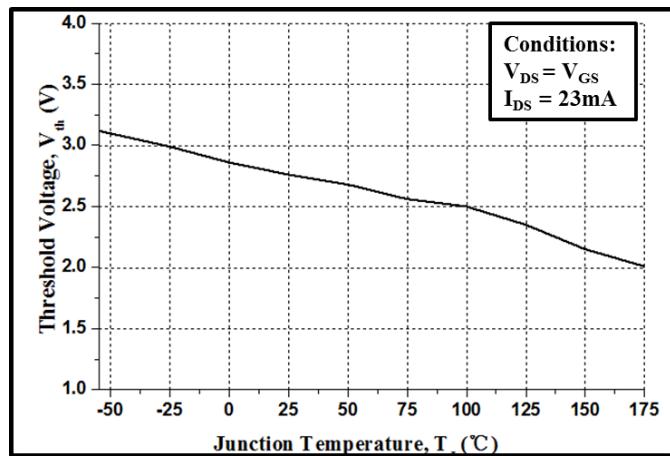


Figure 11. Threshold Voltage vs. Temperature

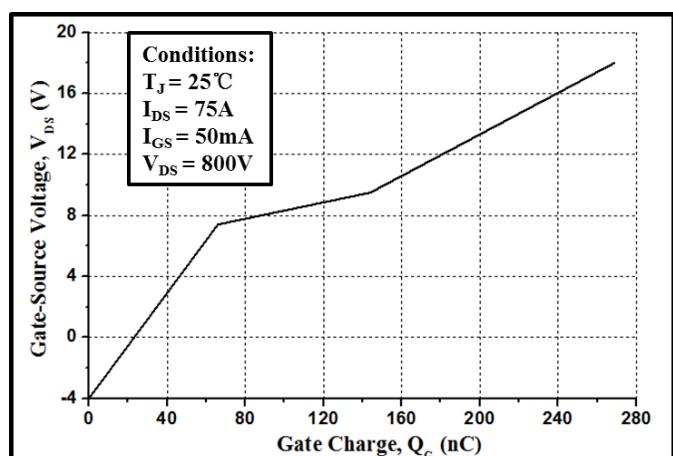


Figure 12. Gate Charge Characteristics

## RATING AND CHARACTERISTICS CURVES (RSM120N120T7L)

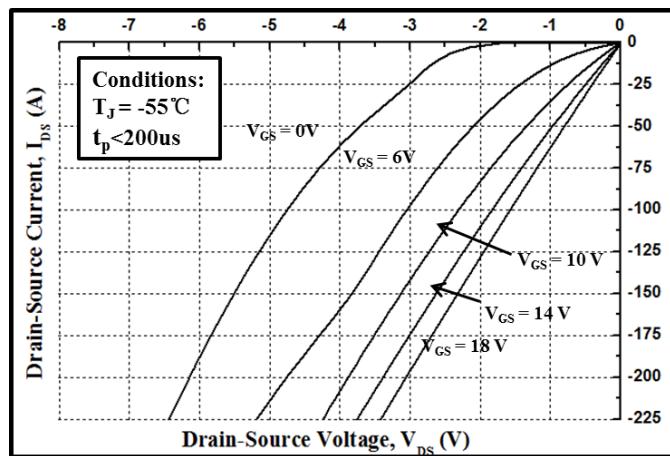


Figure 13. 3rd Quadrant Characteristic at  $-55^\circ\text{C}$

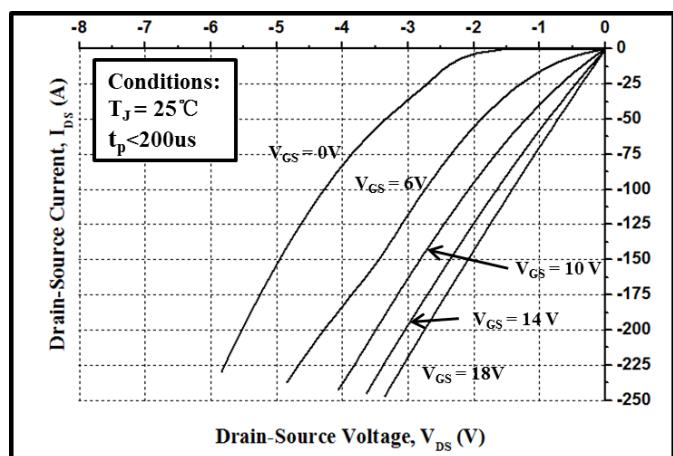


Figure 14. 3rd Quadrant Characteristic at  $25^\circ\text{C}$

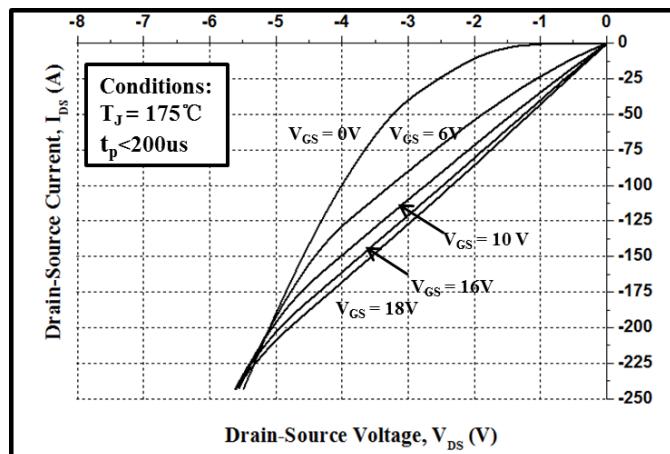


Figure 15. 3rd Quadrant Characteristic at  $175^\circ\text{C}$

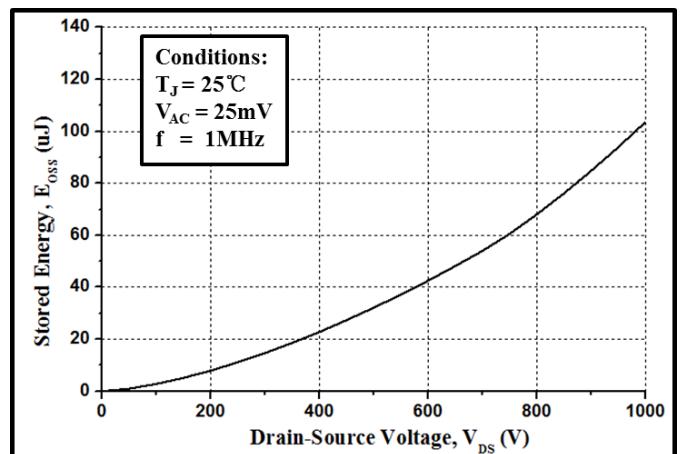


Figure 16. Output Capacitor Stored Energy

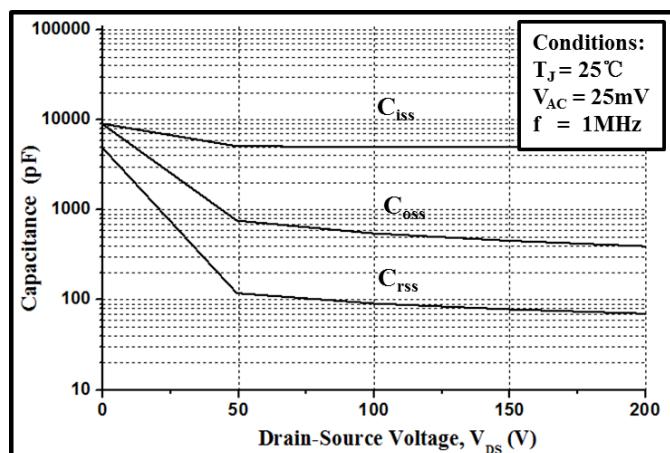


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

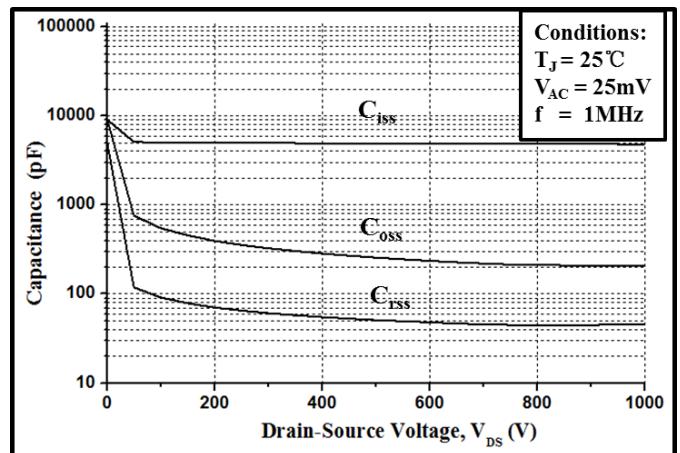


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

## RATING AND CHARACTERISTICS CURVES (RSM120N120T7L)

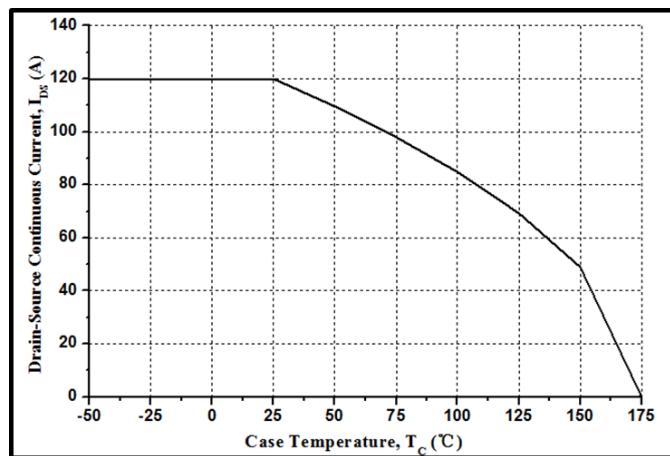


Figure 19. Continuous Drain Current vs.  
Case Temperature

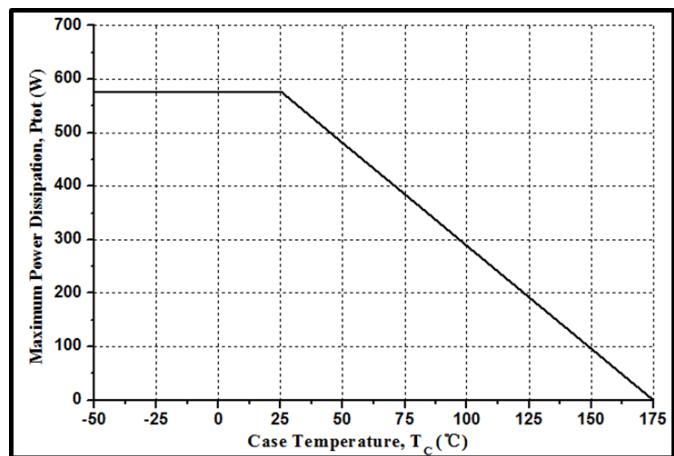


Figure 20. Maximum Power Dissipation vs.  
Case Temperature

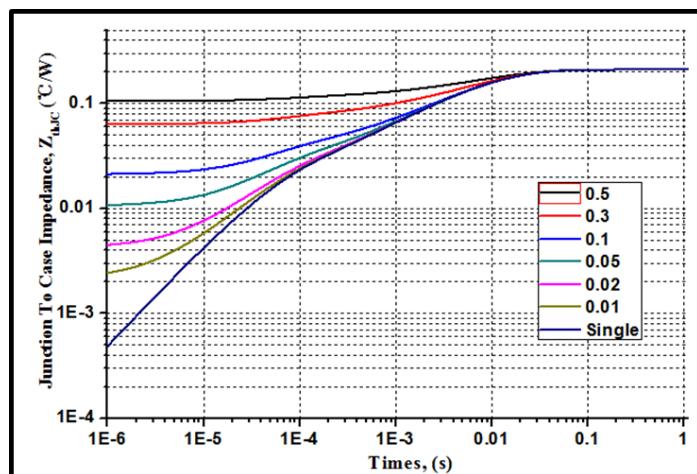


Figure 21. Transient Thermal Impedance  
(Junction - Case)

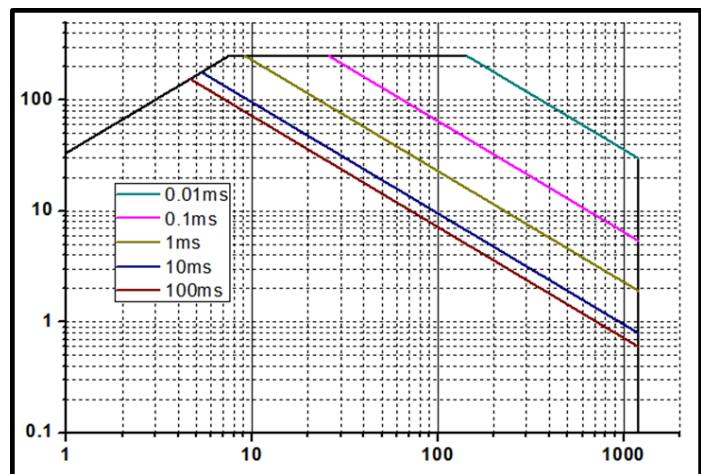


Figure 22. Safe Operating Area

## Test Circuit Schematic

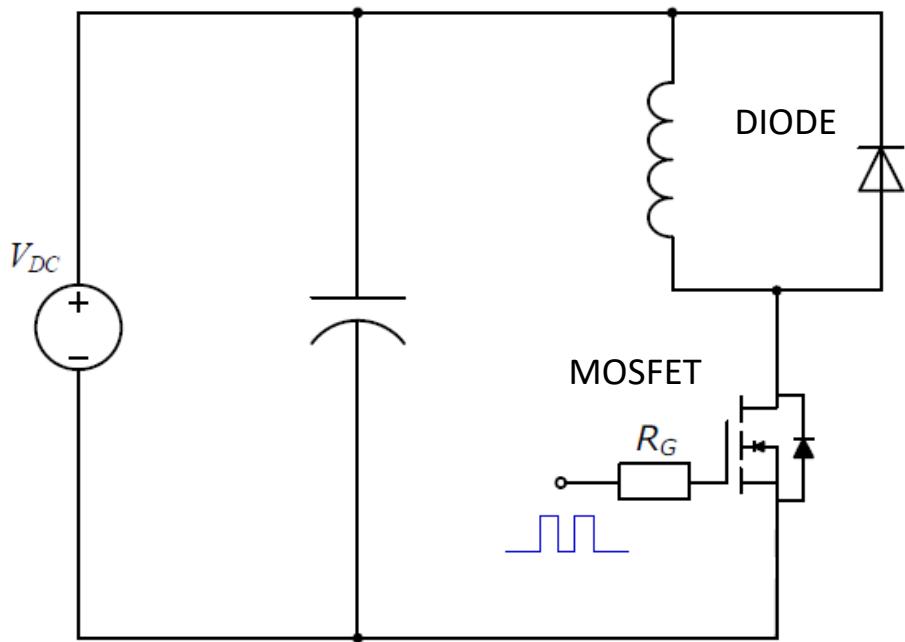
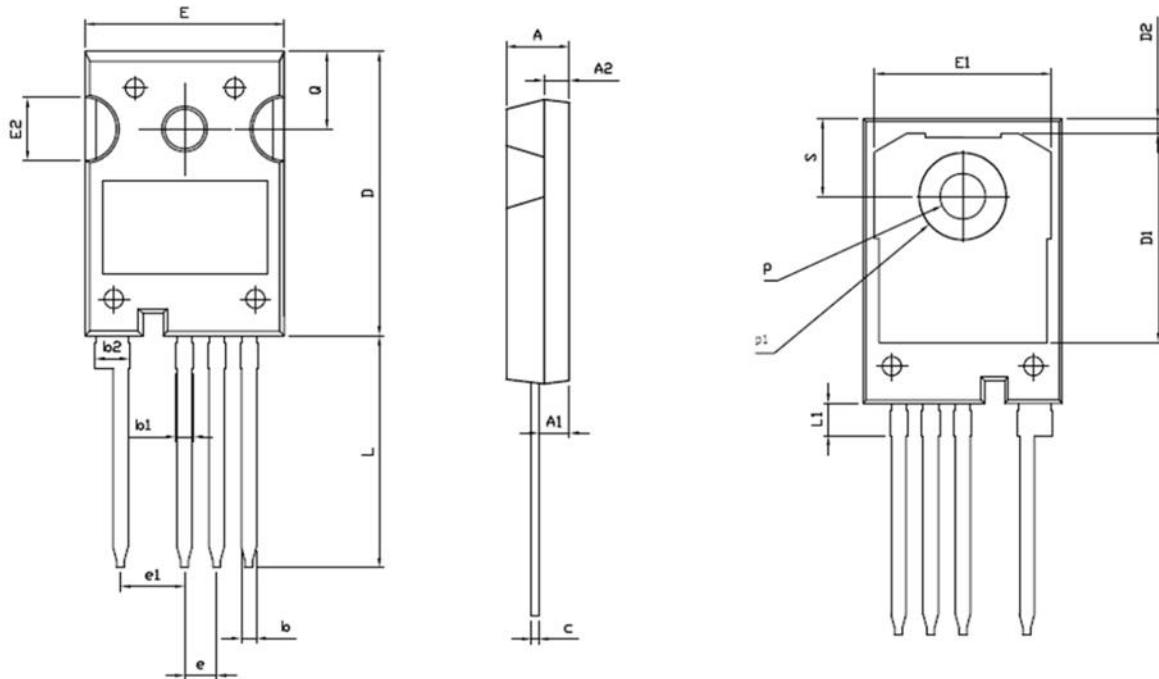
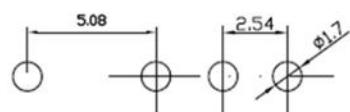


Figure 23. Clamped Inductive Switching  
Waveform Test Circuit

## Package Dimensions



RECOMMENDED LAND PATTERN



UNIT: mm

	MIN	NOM	MAX
A2	1.85	2.00	2.15
b	1.05	1.20	1.35
b1	1.00	1.30	1.60
b2	2.35	2.65	2.95
c	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.50	17.00
D2	0.97	1.17	1.37
e	2.34	2.54	2.74
e1	4.88	5.08	5.28
E	15.60	15.80	16.00
E1	13.50	14.00	14.50
E2	4.80	5.00	5.20
L	18.08	18.38	18.68
L1	2.38	2.58	2.78
p	3.50	3.60	3.70
p1	6.60	6.80	7.00
Q	6.00	6.15	6.30
S	6.00	6.15	6.30

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